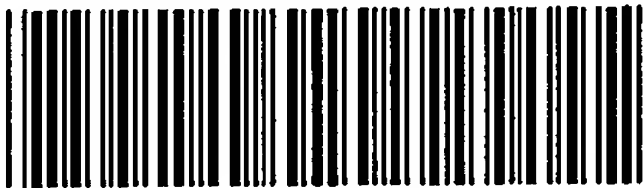


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/645,882	WELCH, JOHN T.	
	Examiner	Art Unit	
	Richard L. Leung	3744	

SEARCHED			
Class	Subclass	Date	Examiner
62	3.2, 3.3, 3.4, 3.7	9/9/2005	RLL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Consulted Examiner Doerrler AU3744	9/9/2005	RLL
See EAST search history printout	10/3/2005	RLL